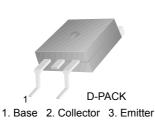
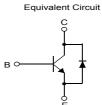


FJD5304D High Voltage Fast Switching Transistor

Features

- Built-in Free Wheeling Diode
- Wide Safe Operating Area
- Small Variance in Storage Time
- Suitable for Electronic Ballast Application





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter	Value	Units	
V _{CBO}	Collector-Base Voltage	700	V	
V _{CEO}	Collector-Emitter Voltage	400	V	
V _{EBO}	Emitter-Base Voltage	12	V A	
I _C	Collector Current (DC)	4		
I _{CP}	* Collector Current (Pulse)	8	A	
I _B	Base Current (DC)	2	A A W	
I _{BP}	* Base Current (Pulse)	4		
P _C	Collector Dissipation ($T_C = 25^{\circ}C$)	30		
TJ	Junction Temperature	150	°C	
T _{STG}	Storage Temperature	-55 ~ 150	°C	

* Pulse Test: PW = $300\mu s$, Duty Cycle = 2% Pulsed

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
J5304D	FJD5304DTM	D-PAK	13" Dia	-	2500
J5304D	FJD5304DTF	D-PAK	13" Dia	-	2000

FJD5304D
High
Voltage
Fast
ge Fast Switching Tran
Transistor

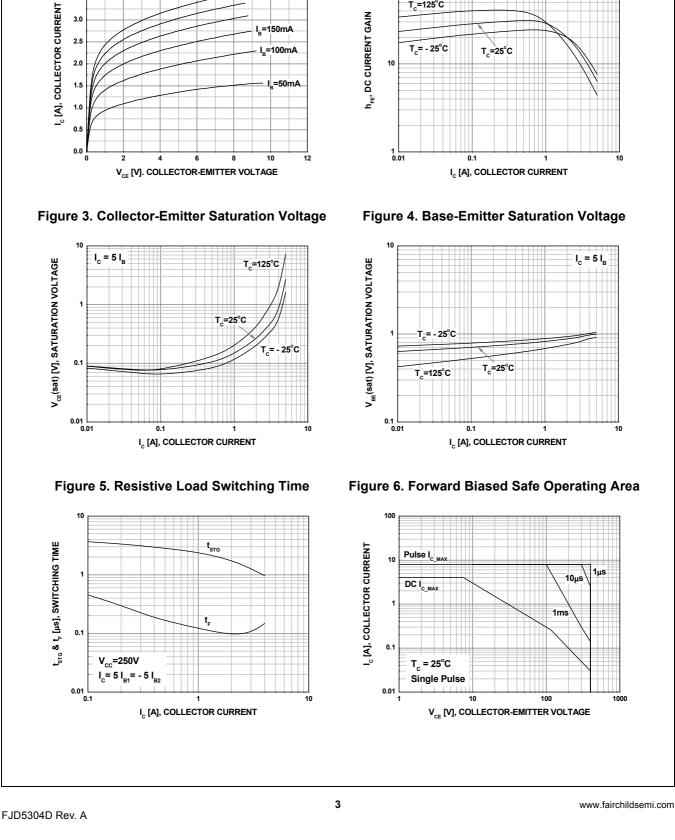
Symbol	Parameter	Conditions	Min.	Тур.	Max	Units
BV _{CBO}	Collector-Base Breakdown Voltage	I _C = 1mA, I _E = 0	700			V
BV _{CEO}	Collector-Emitter Breakdown Voltage	I _C = 5mA, I _B = 0	400			V
BV _{EBO}	Emitter-Base Breakdown Voltage	I _E = 1mA, I _C = 0	12			V
I _{CES}	Collector Cut-off Current	V _{CB} = 700V, I _E = 0			100	μA
I _{CEO}	Collector Cut-off Current	V _{CB} = 400V, I _B = 0			250	μA
I _{EBO}	Emitter Cut-off Current	V _{EB} = 12V, I _C = 0			1	mA
h _{FE}	DC Current Gain	$V_{CE} = 5V, I_{C} = 10mA$ $V_{CE} = 5V, I_{C} = 2.0A$	10 8		40	
V _{CE(sat)}	Collector-Emitter Saturation Voltage	I _C = 0.5A, I _B = 0.1A			0.7	V
		I _C = 1.0A, I _B = 0.2A			1.0	V
		I _C = 2.5A, I _B = 0.5A			1.5	V
V _{BE(sat)}	Base-Emitter Saturation Voltage	I _C = 0.5A, I _B = 0.1A			1.1	V
		I _C = 1.0A, I _B = 0.2A			1.2	V
		I _C = 2.5A, I _B = 0.5A			1.3	V
t _{STG}	Storage Time	V _{CLAMP} =200V, I _C =2.0A		0.6		μs
t _F	Fall Time	I _{B1} =0.4A, V _{BE} (off)=-5V, L=200μH		0.1		μs
t _{STG}	Storage Time	V _{CC} =250V, I _C =2.0A			2.9	μs
t _F	Fall Time	I _{B1} =0.4A, I _{B2} =-0.4A, T _P =30μs		0.2		μS

FJD5304D High Voltage Fast Switching Transistor

Figure 2. DC Current Gain

100

T_=125°C



Typical Performance Characteristics

Figure 1. Static Characterstic

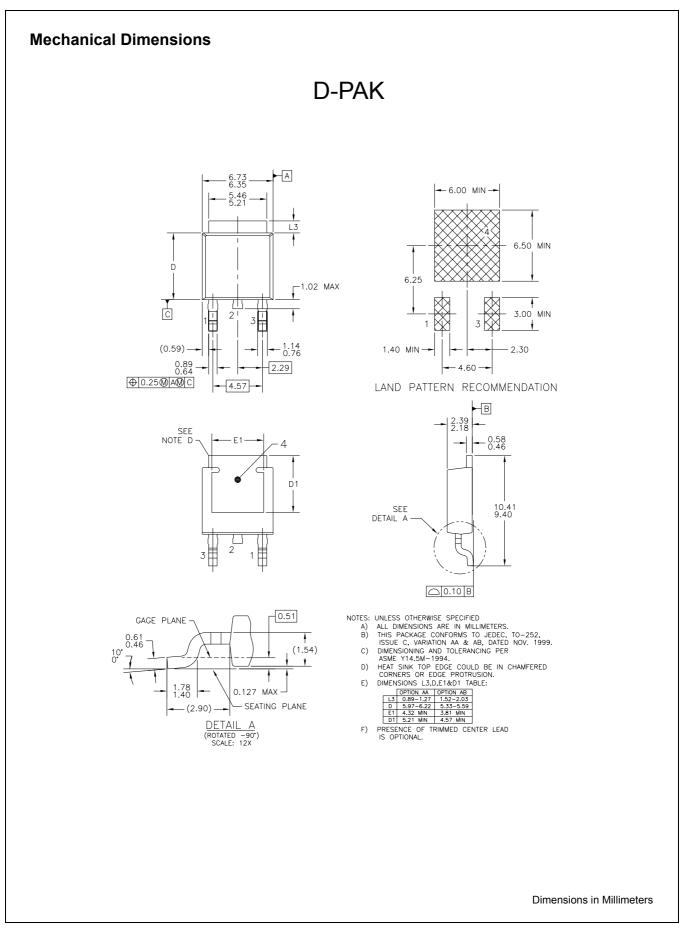
=300mA

4.0

3.5

3.0

Typical Performance Characteristics (Continued) Figure 7. Reverse Biased Safe Operating Area Figure 8. Power Derating Curve P_c [W], COLLECTOR POWER DISSIPATION Vcc=50V, L = 1mH I_{B1}=1A, I_{B2} = -1A g I_c [A], COLLECTOR CURRENT 0 0 L 0 $V_{_{CE}}$ [V], COLLECTOR-EMITTER VOLTAGE T_c [°C], CASE TEMPERATURE



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	Formative or In Design First Production Full Production

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